PQ3198 POWER QUALITY ANALYZER

Measurement Guide

Mar. 2019 Edition1 PQ3198A981-00 19-03H



Thank you for purchasing the Hioki PQ3198 Power Quality Analyzer.

This guide introduces the basic measurement procedure to firsttime users.

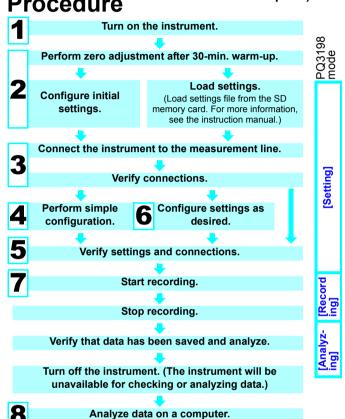
Before using the instrument, be sure to read the instruction manual



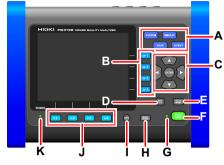
Read First

Measurement **Procedure**

(Number indicates reference step no.)



Key functions



A. Menu keys

SYSTEM:

Configure various settings and event thresholds

Display instantaneous values and waveforms

TIMEPI OT Display measurement data as a time series graph. **FVFNT**

Display measured events as a list.

B. DF keys

Select detailed screen display from each

C. Cursor kev. ENTER kev Select and accept settings.

D. ESC kev

Cancel selections and changes.

E. DATA RESET key

Delete displayed measurement data (Data stored on the SD memory card will not be deleted.

F. START/STOP key

Start and stop recording

G. START/STOP LED

Recording standby: Flashing

Steady green

H. MANU EVENT key

Generate events

being displayed.

I. COPY key

Record data on screen currently

J. F keys

Select and change display

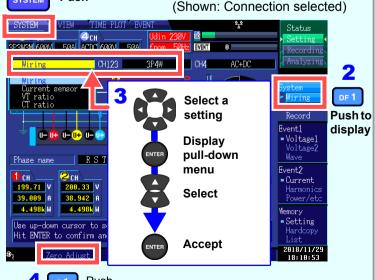
K. POWER LED

When using AC adapter: Steady

When using battery Steady

Initial

Perform zero adjustment. Configure the connection and



Verify connections to the measurement line.

Connect the instrument to the measurement line, referring to the connection diagram shown on the screen.

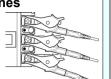


Verify that the connections are correct, referring to the vector diagrams and measured values on the [Wiring] screen.

If you discover an error, verify the connections and return to step (2) to reconfigure the initial settings.

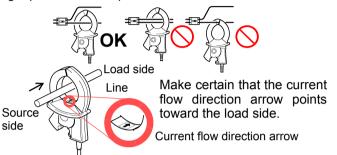
Attach voltage cords to measurement lines

Securely clip the leads to metal parts such as terminal screw terminals or bus bars. (Example: Secondary side of breaker)



Applying clamp sensors to lines to be measured

Always clamp the instrument around only one conductor. Clamping the instrument around two or more of conductors in a bundle prevents the instrument from measuring any current regardless of whether the measurement target is a single-phase or three-phase circuit.



Simple configuration

Example: Configuring settings for the abnormal voltage detection pattern

SYSTEM Push Settings such as the current range, nominal input voltage, measurement frequency, and event thresholds will be automatically configured based on the selected connection mode.

(You will need to set the measurement line type, current sensor type, and external VT/CT ratio.) Select from the five available patterns according to your objective. To investigate the cause of a power supply issue, select the abnormal voltage detection pattern. To investigate power supply quality (i.e., to monitor a power system), select the basic power supply quality measurement pattern.



■ Easy setting course patterns Setting Contents

apowem run arung Analyzing	3	F
System Wirring Push to display	Voltage event detection	Monitors voltage factors (dips, swells, interruptions, etc.) and frequency to detect events. This pattern is used to investigate the cause of equipment malfunctions. The TIMEPLOT interval will be set to 1 minute.
Columbia Columbia	Standard Power Quality	Monitors voltage factors (dips, swells, interruptions, etc.), frequency, current, voltage and current harmonics, and other characteristics to detect events. This pattern is primarily used to monitor systems. The TIMEPLOT interval will be set to 10 minutes.
Push (The following screen will be displayed.)	Inrush Current	Measures rush current. The TIMEPLOT interval will be set to 1 minute, and the rush current threshold will be set to 200% of the RMS current (reference value) set during simple configuration.
Select [Easy setting course] Display pull-down menu	Record measured value	Records measured values over an extended period of time using a TIMEPLOT interval of 10 minutes. All event detection functionality other than manual, start, and stop events is turned off.
CH123 C SP3M3M AC CT7136 600A CT713 I I mirute SD 95	EN50160	Performs EN50160-compliant measurement. Standard-compliant evaluation and analysis can be performed by analyzing data using the application software PQ ONE, which is supplied with the instrument.

Description

■ For more information about settings, see the instruction manual.

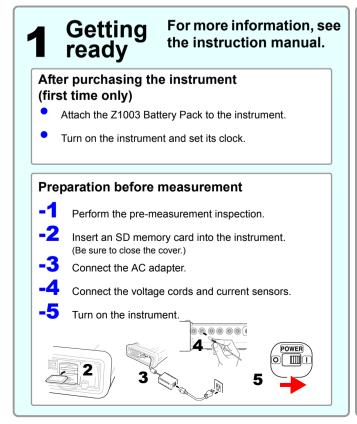


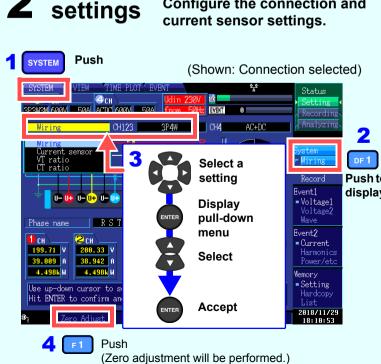


6 Verify [Declared input voltage] and [Frequency] These values will be set automatically. Change the values if they are incorrect.

Push (A message informing you that the simple configuration process is starting will be displayed. Select [Yes] to continue with the process.)

Accept





Verifying settings and connections

-1. Are measured values or crest factors out of range?

If you see any warning indicators, the clamp sensor, range, or connection settings may be incorrect. Verify the connections and return to step (2) to reconfigure the initial settings.

Warning indicators: Values shown in red as below.



(Current and crest factor out of range)



(Voltage and crest factor out of range)

-2. Are too many events occurring?

(Is the **EVENT** icon shown continuously?)

If too many events are occurring, check which events are being generated on the event list on the **[EVENT]** screen (see step 7) after recording some data and then change the thresholds for the problematic events.

Alternately, wiring (connections) to the measurement line may be incorrect. Verify the connections.



■ Up to 9999 events can be recorded. (when [Max. recordable events] is set to [9999].)

(changing settings)

User settings

Select

[(Upper limit)]

Measurement data continues to be recorded even when the number of events exceeds 9999.

Example: To change the voltage

level setting

RMS (Upper limit)

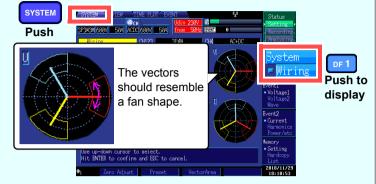
Push to

display

threshold

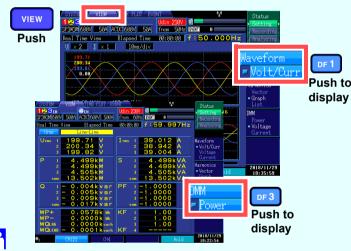
-3. Are the voltage and current phase relationships shown properly in the vector diagrams?

If not, the wiring (connections) to the measurement line or current sensor orientations may be incorrect. Verify the connections and current sensor orientations.

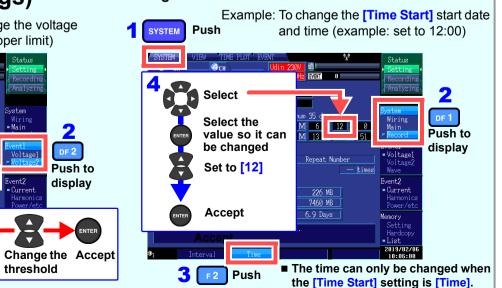


-4. Are waveforms and measured values shown properly?

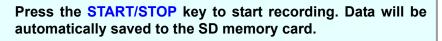
If waveforms and measured values are not shown properly, the clamp sensor, range, or connection settings may be incorrect. Return to step 2 to reconfigure the initial settings. Alternately, wiring (connections) to the measurement line or current sensor orientations may be incorrect.



You can change event thresholds, the recording start date and time, recorded items, and other settings as desired.

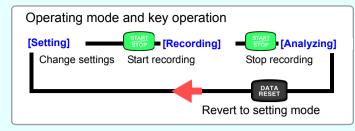


Starting recording





- When recording, the operating mode indicator on the top right of the screen will show [Recording].
- To change a setting, set the operating mode to [Setting]. (Settings cannot be changed while recording or analyzing.)



Monitoring event

You can check whether events are occurring and the num-

Press the EVENT key to display the [EVENT] screen.

Select an event and press the **ENTER** key to view waveforms and measured values at the time of its generation on the [VIEW]

generation

ber of events occurring with the event list.

TIME PLOT

Monitoring fluctuations in measured values

You can view measured items in the form of a time series graph. You can also display flicker values as a graph or list.

Press the TIMEPLOT key to display the ITIMEPLOTI screen. You can change the screen display with the DF keys.



■ To hold waveforms and values

Hold function is valid on the

occurrence

F4 Push

Event list

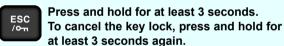
Select an eve

Waveforms at event

an event

screen.

■ To active the key lock



Event list details

■ To check instantaneous values



(Switch screens with the **DF** key.)



Select an event from the

event list

details

When multiple events occurred at the same

time, "1/N" (where N indicates the total number

of events) is displayed at the top of the list.

Analysis

[VIEW] screen only.

After recording has stopped, data can be analyzed on a computer using the application software PQ ONE, which is supplied with the instrument.

■ For more information, see the PQ ONE instruction manual (on the included CD-ROM).



Viewing data

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50.000 0/410

Use event statistics functionality to analyze measurement data at a high level of detail. By reviewing event occurrence by date or time, you can discover events that are likely to occur at a specific time or on a specific day of the week.

Easily create graphs to suit your needs

Organize time plot graphs by convenient times or group three phases of data together on a single graph.

Converting data

Convert event data and time plot data (binary data) to the CSV format so that it can be opened with a spreadsheet application on a computer.

Creating reports

Output information shown on the screen as-is in the form of a report. Create reports that suit your needs without the need to configure complex settings.

Display file data in list form

Drag and drop folders containing measurement data to display a list of settings information and event occurrence data for all the data contained in the folder.

Calculating demand and integral power

Display a demand graph, or display the maximum and integrated power values for a specified interval.